

March 2013

FQD4N25 / FQU4N25 N-Channel QFET MOSFET **250 V, 3 A, 1.75**Ω

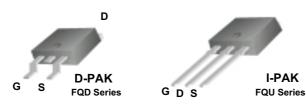
Description

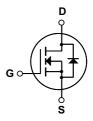
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

I-PAK

- 3 A, 250 V, $R_{DS(on)}$ = 1.75 Ω (Max) $@V_{GS}$ = 10 V, $I_D = 1.5 A$
- Low Gate Charge (Typ. 4.3 nC)
- Low Crss (Typ. 4.8 pF)
- 100% Avalanche Tested





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD4N25 / FQU4N25	Unit
V _{DSS}	Drain-Source Voltage		250	V
I _D	Drain Current - Continuous (T _C = 25°C)		3.0	Α
	- Continuous (T _C = 100°C)		1.9	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	12	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	52	mJ
I _{AR}	Avalanche Current	(Note 1)	3.0	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.7	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C) - Derate above 25°C		37	W
			0.29	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Off Cha BV _{DSS} \(\DSS\)	aracteristics					
ΔBV _{DSS}						
	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	250			V
	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.22		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 250 V, V _{GS} = 0 V			1	μА
		V _{DS} = 200 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics		"		ı	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.5 A		1.38	1.75	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 1.5 A (Note 4)		2.4		S
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		155 35	200 45	pF pF
C _{rss}	Reverse Transfer Capacitance	1.5 10112		4.8	6.5	pF
	ing Characteristics					
t _{d(on)}	Turn-On Delay Time			6.8	25	ns
t _r	Turn-On Rise Time	V _{DD} = 125 V, I _D = 3.6 A,		45	100	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$		6.4	25	ns
t _f	Turn-Off Fall Time	(Note 4, 5		22	55	ns
Q _g	Total Gate Charge	V _{DS} = 200 V, I _D = 3.6 A,		4.3	5.6	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 10 \text{ V}$		1.3		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5		2.1		nC
	Source Diede Characteristics as	nd Maximum Patings		I		1
s	Maximum Continuous Drain-Source Diode Forward Current				3.0	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				12	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V, } I_{S} = 3.0 \text{ A}$			1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 3.6 A,		110		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs (Note 4)		0.35		μC

- Notes:
 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 9.3mH, I_{AS} = 3.0A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} \leq 3.6A, di/dt \leq 300A/μs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300μs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

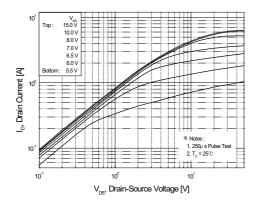


Figure 1. On-Region Characteristics

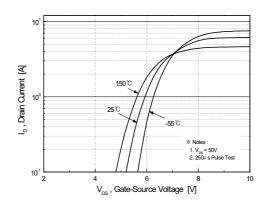


Figure 2. Transfer Characteristics

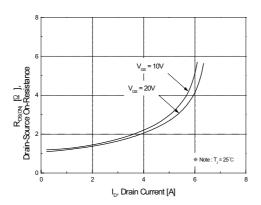


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

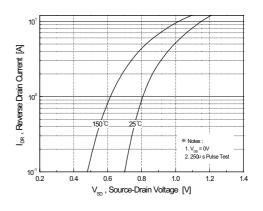


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

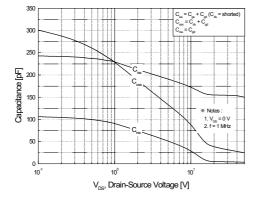


Figure 5. Capacitance Characteristics

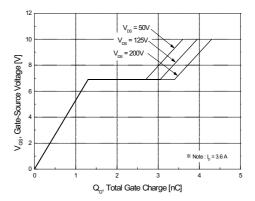
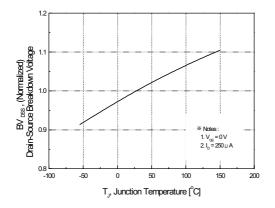


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)



25

(Sezination VI) - 60 80 100

1.5

0.0

-100

-50

0 50

100

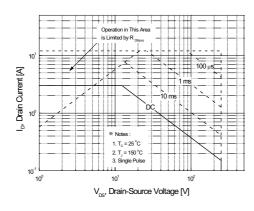
150

200

T_y, Junction Temperature [°C]

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



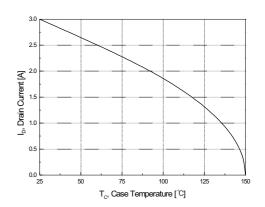


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

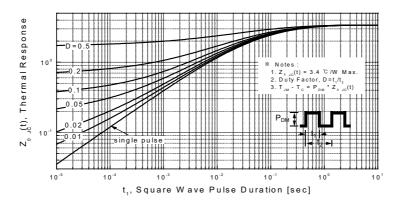
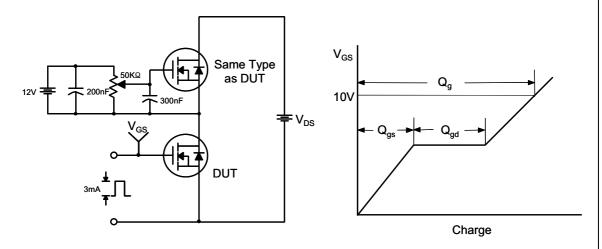
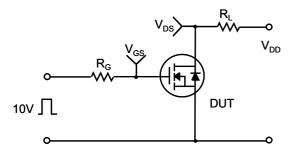


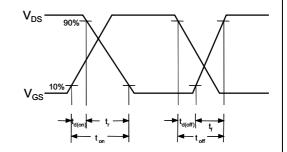
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

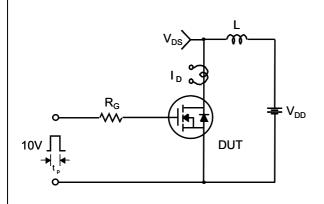


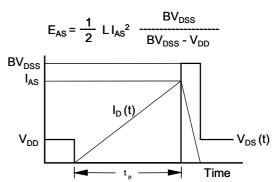
Resistive Switching Test Circuit & Waveforms



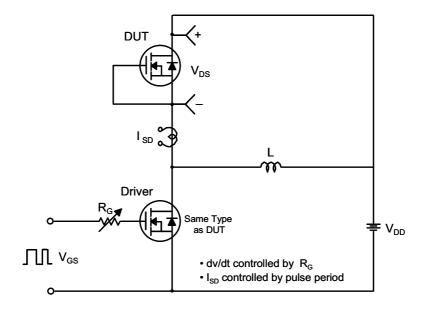


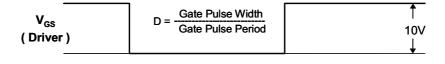
Unclamped Inductive Switching Test Circuit & Waveforms

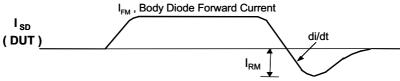




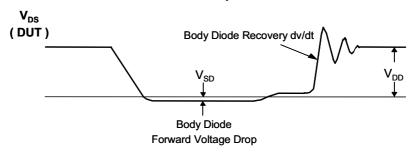
Peak Diode Recovery dv/dt Test Circuit & Waveforms





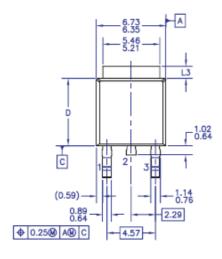


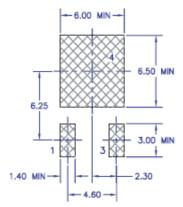
Body Diode Reverse Current



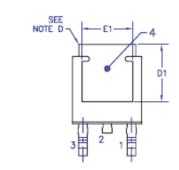
Mechanical Dimensions

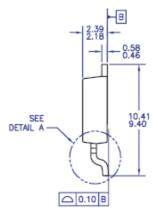
D - PAK

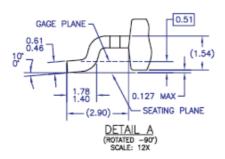








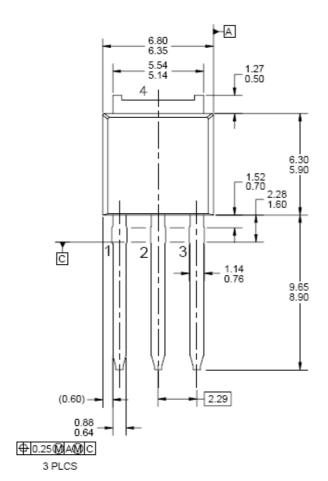


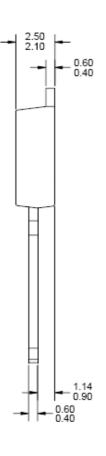


Dimensions in Millimeters

Mechanical Dimensions

I - PAK







Dimensions in Millimeters





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